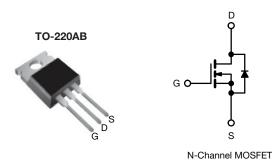


Power MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	200 V			
R _{DS(on)} (Ω)	$V_{GS} = 5 V$	0.40		
Q _g (Max.) (nC)	40			
Q _{gs} (nC)	5.5			
Q _{gd} (nC)	24			
Configuration	Single			

FEATURES

- · Dynamic dV/dt rating
- · Repetitive avalanche rated
- · Logic-level gate drive
- R_{DS(on)} specified at V_{GS} = 4 V and 5 V
- 150 °C operating temperature
- Fast switching
- Ease of paralleling
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION				
Package	TO-220AB			
Lead (Pb)-free	IRL630PbF			
Lead (Pb)-free and halogen-free	IRL630PbF-BE3			

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, un	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V _{DS}	200		
Gate-source voltage			V_{GS}	± 10	V	
Continuous drain current	V _{GS} at 5 V	T _C = 25 °C	- I _D	9.0		
		$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		5.7	Α	
Pulsed drain current ^a			I _{DM}	36	1	
Linear derating factor				0.59	W/°C	
Single pulse avalanche energy ^b			E _{AS}	250	mJ	
Repetitive avalanche current ^a			I _{AR}	9.0	Α	
Repetitive avalanche energy ^a			E _{AR}	7.4	mJ	
Maximum power dissipation	T _C =	25 °C	P_{D}	74	W	
Peak diode recovery dV/dt c			dV/dt	5.0	V/ns	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) d	For 10 s		_	300 d	7	
Mounting torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 4.6 mH, R_g = 25 Ω , I_{AS} = 9.0 A (see fig. 12)
- c. $I_{SD} \le 9.0$ A, $dV/dt \le 120$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C
- d. 1.6 mm from case



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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	-	62		
Case-to-sink, flat, greased surface	R _{thCS}	0.50	-	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	1.7		

PARAMETER	SYMBOL	TEST (MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	V _{GS} = 0	200	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference t	-	0.27	-	V/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		1.0	-	2.0	V
Gate-source leakage	I _{GSS}	V _{GS} = ± 10		-	-	± 100	nA
Zero gate voltage drain current	I _{DSS}	V _{DS} = 20	V _{DS} = 200 V, V _{GS} = 0 V		-	25	
		V _{DS} = 160 V, V	V _{DS} = 160 V, V _{GS} = 0 V, T _J = 125 °C			250	μA
Drain-source on-state resistance		V _{GS} = 5.0 V	I _D = 5.4 A ^b	1	-	0.40	Ω
	R _{DS(on)}	V _{GS} = 4.0 V	I _D = 4.5 A ^b	-	-	0.50	
Forward transconductance	9 _{fs}	$V_{DS} = 50 \text{ V}, I_D = 5.4 \text{ A}^{b}$		4.8	-	-	S
Dynamic							
Input capacitance	C_{iss}	$V_{GS} = 0 \text{ V}$ $V_{DS} = 25 \text{ V}$ f = 1.0 MHz, see fig. 5		ı	1100	-	pF
Output capacitance	C _{oss}			ı	220	-	
Reverse transfer capacitance	C_{rss}			1	70	-	
Total gate charge	Q_g			-		40	nC
Gate-source charge	Q _{gs}	V _{GS} = 10 V	$I_D = 9.0 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 ^b	ı	-	5.5	
Gate-drain charge	Q_{gd}			1	-	24	
Turn-on delay time	t _{d(on)}			-	8.0	-	
Rise time	t _r	V_{DD} = 100 V, I_D = 9.0 A R_g = 6.0 Ω , R_D = 11 Ω , see fig. 10 ^b		-	57	-	- ns
Turn-off delay time	t _{d(off)}			-	38	-	
Fall time	t _f			1	33	-	
Internal drain inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		ı	4.5	-	- nH
Internal source inductance	L _S			-	7.5	-	
Drain-Source Body Diode Characteristic	s						
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	9.0	- A
Pulsed diode forward current ^a	I _{SM}			ı	-	36	
Body diode voltage	V_{SD}	$T_J = 25 ^{\circ}C, I_S = 9.0 A, V_{GS} = 0 V^b$		ı	-	2.0	V
Body diode reverse recovery time	t _{rr}	- T _J = 25 °C, I _F = 9.0 A, dl/dt = 100 A/μs ^b		ı	230	350	ns
Body diode reverse recovery charge	Q_{rr}			-	1.7	2.6	μC
Forward turn-on time	t _{on}	Intrinsic turn-	-on is do	n is dominated by L _S and L _D)			

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width $\leq 300~\mu s;~duty~cycle \leq 2~\%$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

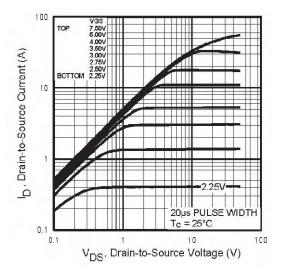


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

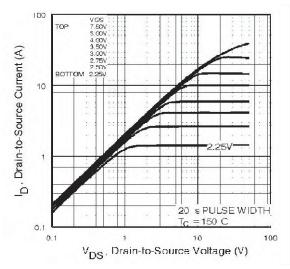


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

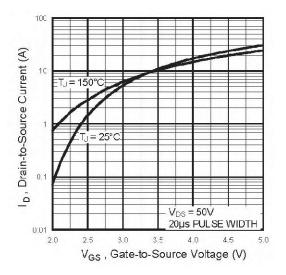


Fig. 3 - Typical Transfer Characteristics

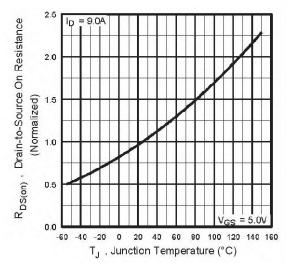


Fig. 4 - Normalized On-Resistance vs. Temperature



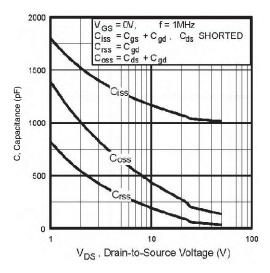


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

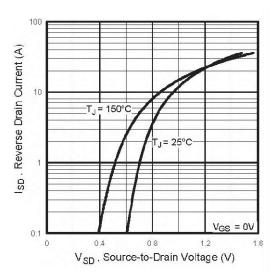


Fig. 7 - Typical Source-Drain Diode Forward Voltage

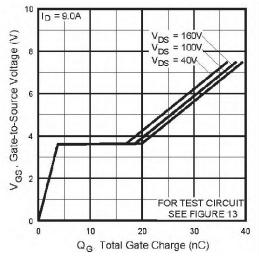


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

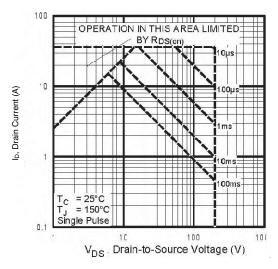


Fig. 8 - Maximum Safe Operating Area



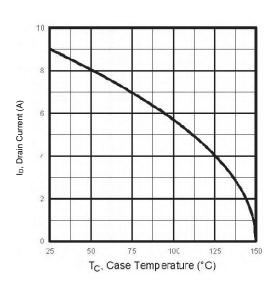


Fig. 9 - Maximum Drain Current vs. Case Temperature

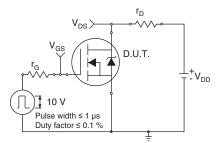


Fig. 10a - Switching Time Test Circuit

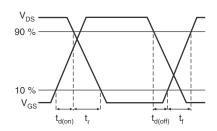


Fig. 10b - Switching Time Waveforms

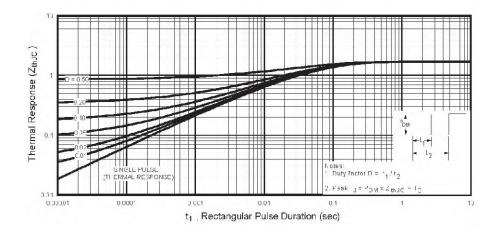


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



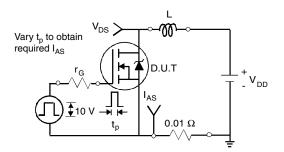


Fig. 12a - Unclamped Inductive Test Circuit

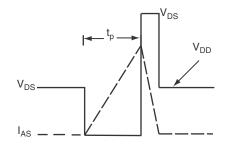


Fig. 12b - Unclamped Inductive Waveforms

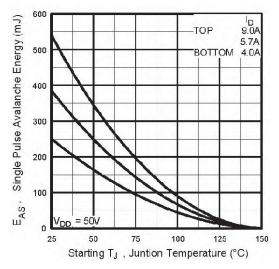


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

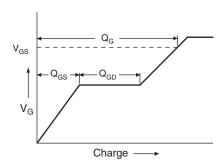


Fig. 13a - Basic Gate Charge Waveform

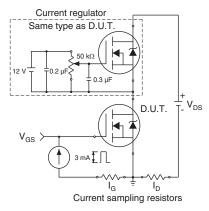
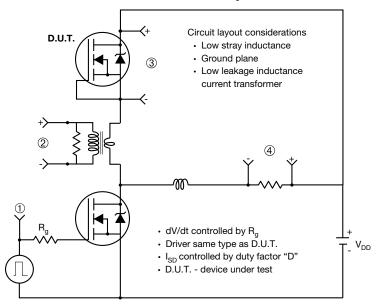


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



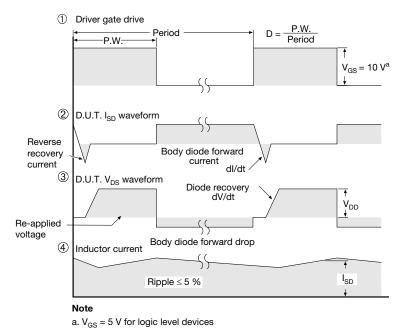


Fig. 14 - For N-Channel

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